

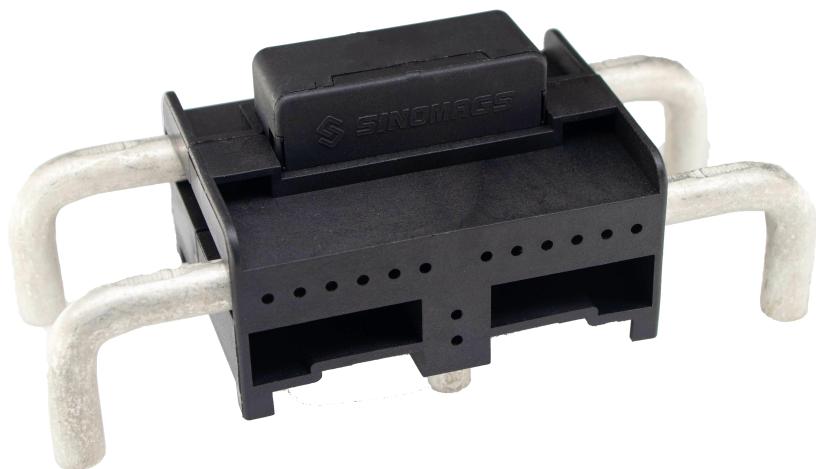


CURRENT SENSOR

PRODUCT SERIES: SFG-X.XP/P3

PRODUCT PART NUMBER: SFG-1.5P/P3,
SFG-3.0P/P3,
SFG-5.0P/P3

Version: Ver 2.9



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1. Description

Features

- Closed loop (compensated) current transducer
- Voltage output
- Insulation voltage for 5 kVAC
- Single supply voltage
- PCB mounting.

Advantages

- High accuracy
- High overload capability
- High insulation capability
- High separation ability
- Low temperature drift
- Degauss and test functions

Applications

- Residual current measurement
- Leakage current measurement in PV inverters
- First human contact protection of PV arrays
- Failure detection in power sources
- Leakage current detection in stacked DC sources
- Communication power.

2. Absolute parameter: SFG-X.XP/P3

Absolute maximum ratings

Parameter	Symbol	Unit	Value
Maximum Supply voltage	$V_C \max$	V	7
Maximum Primary conductor temperature	$T_B \max$	°C	110
Maximum overload capability (100 μs, 500 A/μs)	$\hat{I}_P \max$	A	3300
Maximum Voltage between test winding and secondary pins	$V_d \max$	V	35
Maximum Current of test winding	$I_T \max$	mA	300

Ratings

Parameter	Symbol	Unit	Value
Primary involved potential		V AC/DC	1000
Primary current @ $T_{A\max}=105^\circ\text{C}$	I_P	A	220
Primary current @ $T_{A\max}=85^\circ\text{C}$	I_P	A	300
Secondary supply voltage	U_C	V DC	5
Output voltage	V_{out}	V	0 to 5

Isolation parameters

Parameter	Symbol	Unit	Value	Remark
RMS voltage for AC	V_d	kV	4	test 50 Hz/1 min
Impulse withstand voltage	V_w	kV	10.1	1.2/50μs
Clearance distance (pri. –pri.)	d_{CI}	mm	11	Shortest distance through air
Creepage distance (pri. – pri.)	d_{CP}	mm	11	Shortest path along device body
Clearance distance (pri. –sec.)	d_{CI}	mm	12.1	When mounted on PCB with recommended layout
Creepage distance (pri. –sec.)	d_{CP}	mm	12.1	When mounted on PCB with recommended layout
Comparative tracking index	CTI	V	600	
Application example		V	600 CAT III, PD2	Reinforced insulation, non uniform field
Application example		V	1500 CAT III, PD2	Basic insulation, non uniform field

Environmental and mechanical characteristics

Parameter	Symbol	Unit	Min	Typ	Max	Comment
Ambient operating temperature	T_A	°C	-40		105	
Ambient storage temperature	T_S	°C	-40		105	
Mass	m	g		300		
standard	EN 50178, IEC 61010, UL 508					

3. Electrical data: SFG-1.5P/P3

At $T_A = 25^\circ\text{C}$, $V_C = 5 \text{ V}$.

Parameters	Symbol	Unit	Min	Typ	Max	Remark
Primary nominal residual rms current	I_{PN}	A		1.5		
Primary residual current, measuring range	I_{PM}	A	-2.5		2.5	
Supply voltage	V_C	V	4.75	5	5.5	
Current consumption	I_C	mA		17.5	21.6	$I_P(\text{mA}) / N_a$ $N_a = 1000 \text{ turns}$ $-40^\circ\text{C} \dots 105^\circ\text{C}$
Reference voltage @ $I_P = 0$	V_{ref}	V	2.495	2.5	2.505	Internal reference
External reference voltage	V_{REF}	V	2.3		4	Internal reference of V_{ref} input = 499Ω
Electrical offset current referred to primary	I_{OE}	mA	-12	3.5	12	
Electrical offset voltage	V_{oe}	mV	-25		25	$(V_{out} - V_{ref})$ @ 0 A
Temperature coefficient of VOE @ $I_P = 0$	TCV_{OE}	ppm/K			570	ppm/K of 2.5 V $-40 \dots 105^\circ\text{C}$
Theoretical sensitivity	G_{th}	V/A		0.8		
Sensitivity error	ϵ_G	%	-1.6	0.5	1.6	$R_L > 500 \text{ k}\Omega$
Temperature coefficient of G	TCG	ppm/K		± 400		$-40^\circ\text{C} \dots 105^\circ\text{C}$
Linearity error	ϵ_L	%		0.5	1	
Number of turns (test winding)	N_T			20		$R_L > 500 \text{ k}\Omega$, $di/dt > 5 \text{ A}/\mu\text{s}$
Reaction time @ 10 % of I_{PRN}	t_{ra}	μs		5		$R_L > 500 \text{ k}\Omega$, $di/dt > 5 \text{ A}/\mu\text{s}$
Step response time to 90 % of I_{PN}	t_r	μs		40		$R_L > 500 \text{ k}\Omega$
Frequency bandwidth (-3dB)	BW	kHz		15		$R_L > 500 \text{ k}\Omega$
Noise(1 Hz ~ 10 kHz)	V_{no}	mV rms		10		
Accuracy@ I_{PN} @ $TA = 25^\circ\text{C}$	$X_{25^\circ\text{C}}$	% of I_{PN}		± 1.9		
Accuracy@ I_{PN} @ $TA = 105^\circ\text{C}$	$X_{105^\circ\text{C}}$	% of I_{PN}		± 3.2		

4. Output voltage VS primary current of SFG-1.5P/P3

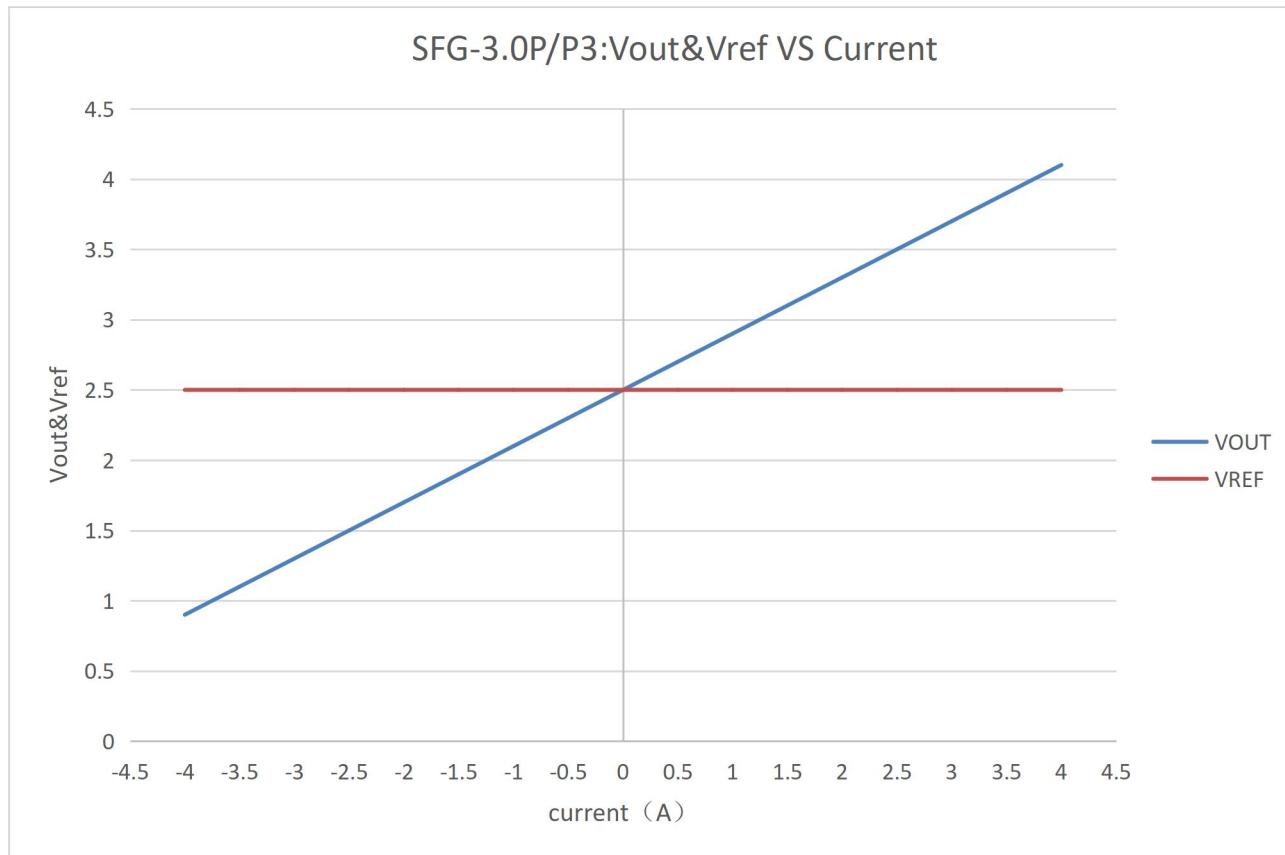


5. Electrical data: SFG-3.0P/P3

At $T_A = 25^\circ\text{C}$, $V_C = 5\text{ V}$.

Parameters	Symbol	Unit	Min	Typ	Max	Remark
Primary nominal residual rms current	I_{PN}	A		3		
Primary residual current, measuring range	I_{PM}	A	-5		5	
Supply voltage	V_C	V	4.75	5	5.5	
Current consumption	I_C	mA		17.5	21.6	$I_P(\text{mA}) / N_a$ $N_a = 1000 \text{ turns}$ $-40^\circ\text{C} \dots 105^\circ\text{C}$
Reference voltage @ $I_P = 0$	V_{ref}	V	2.495	2.5	2.505	Internal reference
External reference voltage	V_{REF}	V	2.3		4	Internal reference of V_{ref} input = 499Ω
Electrical offset current referred to primary	I_{OE}	mA	-24	7	24	
Electrical offset voltage	V_{oe}	mV	-25		25	$(V_{out} - V_{ref})$ @ 0 A
Temperature coefficient of VOE @ $I_P = 0$	TCV_{OE}	ppm/K			570	ppm/K of 2.5 V $-40 \dots 105^\circ\text{C}$
Theoretical sensitivity	G_{th}	V/A		0.4		
Sensitivity error	ϵ_G	%	-1.6	0.5	1.6	$R_L > 500\text{ k}\Omega$
Temperature coefficient of G	TCG	ppm/K		± 400		$-40^\circ\text{C} \dots 105^\circ\text{C}$
Linearity error	ϵ_L	%		0.5	1	
Number of turns (test winding)	N_T			20		$R_L > 500\text{ k}\Omega$, $di/dt > 5\text{ A}/\mu\text{s}$
Reaction time @ 10 % of I_{PRN}	t_{ra}	μs		5		$R_L > 500\text{ k}\Omega$, $di/dt > 5\text{ A}/\mu\text{s}$
Step response time to 90 % of I_{PN}	t_r	μs		40		$R_L > 500\text{ k}\Omega$
Frequency bandwidth (-3dB)	BW	kHz		15		$R_L > 500\text{ k}\Omega$
Noise(1 Hz ~ 10 kHz)	V_{no}	mV rms		10		
Accuracy@ I_{PN} @ $TA = 25^\circ\text{C}$	$X_{25^\circ\text{C}}$	% of I_{PN}		± 1.9		
Accuracy@ I_{PN} @ $TA = 105^\circ\text{C}$	$X_{105^\circ\text{C}}$	% of I_{PN}		± 3.2		

6. Output voltage VS primary current of SFG-3.0P/P3

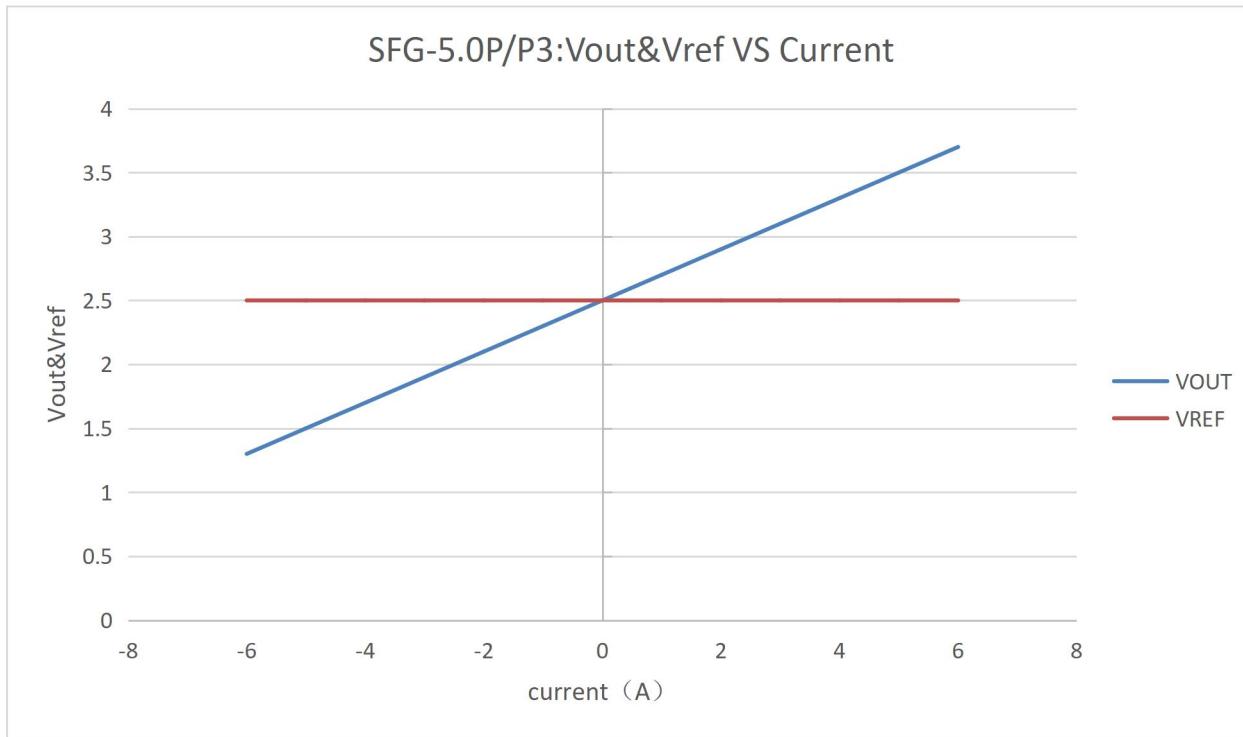


7. Electrical data: SFG-5.0P/P3

At $T_A = 25^\circ\text{C}$, $V_C = 5 \text{ V}$.

Parameters	Symbol	Unit	Min	Typ	Max	Remark
Primary nominal residual rms current	I_{PN}	A		5		
Primary residual current, measuring range	I_{PM}	A	-8		8	
Supply voltage	V_C	V	4.75	5	5.5	
Current consumption	I_C	mA		17.5	21.6	$I_P(\text{mA}) / N_a$ $N_a = 1000 \text{ turns}$ $-40^\circ\text{C} \dots 105^\circ\text{C}$
Reference voltage @ $I_P = 0$	V_{ref}	V	2.495	2.5	2.505	Internal reference
External reference voltage	V_{REF}	V	2.3		4	Internal reference of V_{ref} input = 499 Ω
Electrical offset current referred to primary	I_{OE}	mA	-35	12	35	
Electrical offset voltage	V_{oe}	mV	-25		25	$(V_{out} - V_{ref})$ @ 0 A
Temperature coefficient of VOE @ $I_P = 0$	TCV_{OE}	ppm/K			570	ppm/K of 2.5 V $-40 \dots 105^\circ\text{C}$
Theoretical sensitivity	G_{th}	V/A		0.2		
Sensitivity error	ϵ_G	%	-1.6	0.5	1.6	$R_L > 500 \text{ k}\Omega$
Temperature coefficient of G	TCG	ppm/K		± 400		$-40^\circ\text{C} \dots 105^\circ\text{C}$
Linearity error	ϵ_L	%		0.5	1	
Number of turns (test winding)	N_T			20		$R_L > 500 \text{ k}\Omega$, $di/dt > 5 \text{ A}/\mu\text{s}$
Reaction time @ 10 % of I_{PRN}	t_{ra}	μs		5		$R_L > 500 \text{ k}\Omega$, $di/dt > 5 \text{ A}/\mu\text{s}$
Step response time to 90 % of I_{PN}	t_r	μs		40		$R_L > 500 \text{ k}\Omega$
Frequency bandwidth (-3dB)	BW	kHz		15		$R_L > 500 \text{ k}\Omega$
Noise(1 Hz ~ 10 kHz)	V_{no}	mV rms		10		
Accuracy@ I_{PN} @ $TA = 25^\circ\text{C}$	$X_{25^\circ\text{C}}$	% of I_{PN}		± 1.9		
Accuracy@ I_{PN} @ $TA = 105^\circ\text{C}$	$X_{105^\circ\text{C}}$	% of I_{PN}		± 3.2		

8. Output voltage VS primary current of SFG-5.0P/P3



9. Frequency band width



Fig.1 the frequency band width of SFG-X.XP/P3 series current sensors.

10. Step response time

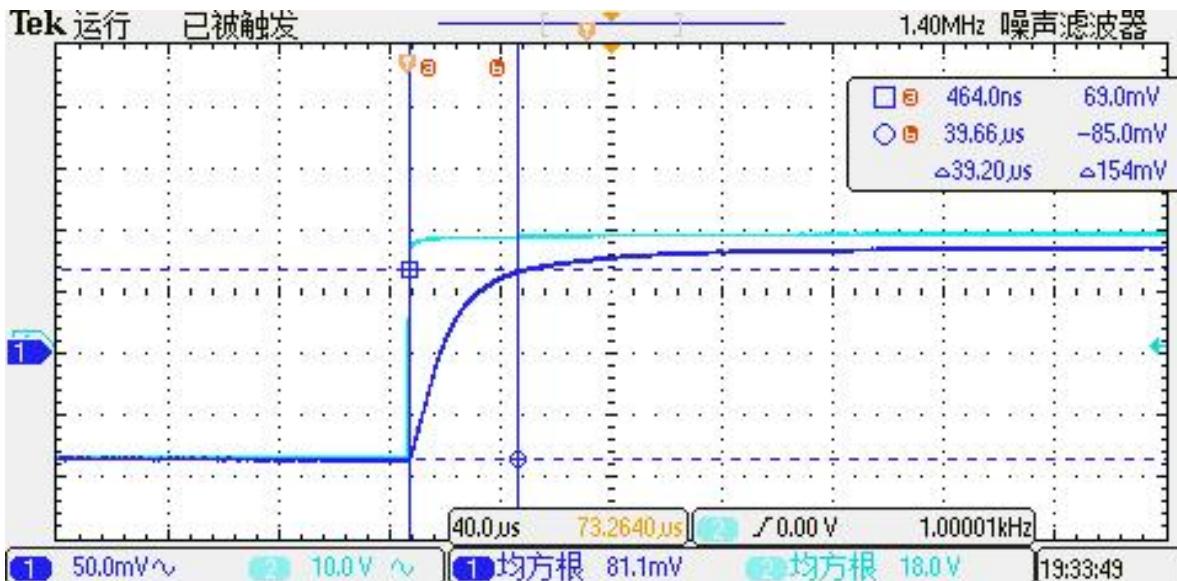
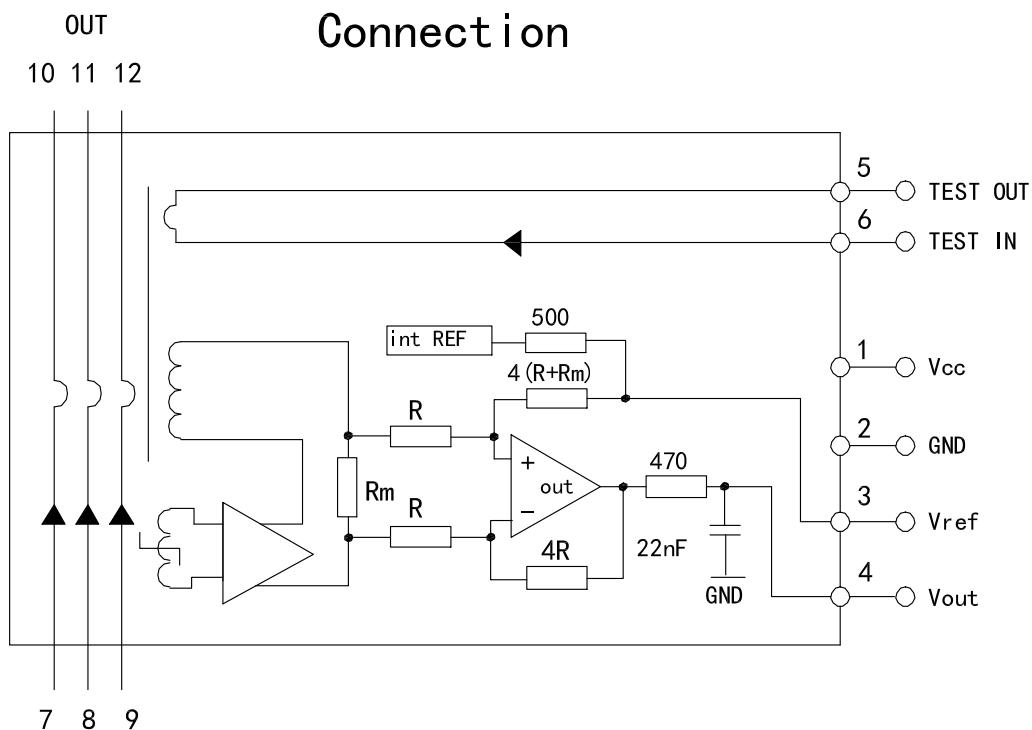


Fig1 is the step response time of SFG-P/P3 current sensors. The light blue is primary current, while the dark blue is output signal of current sensor. The step response time is less than 40μs.

11. SFG- P/P3 Application information

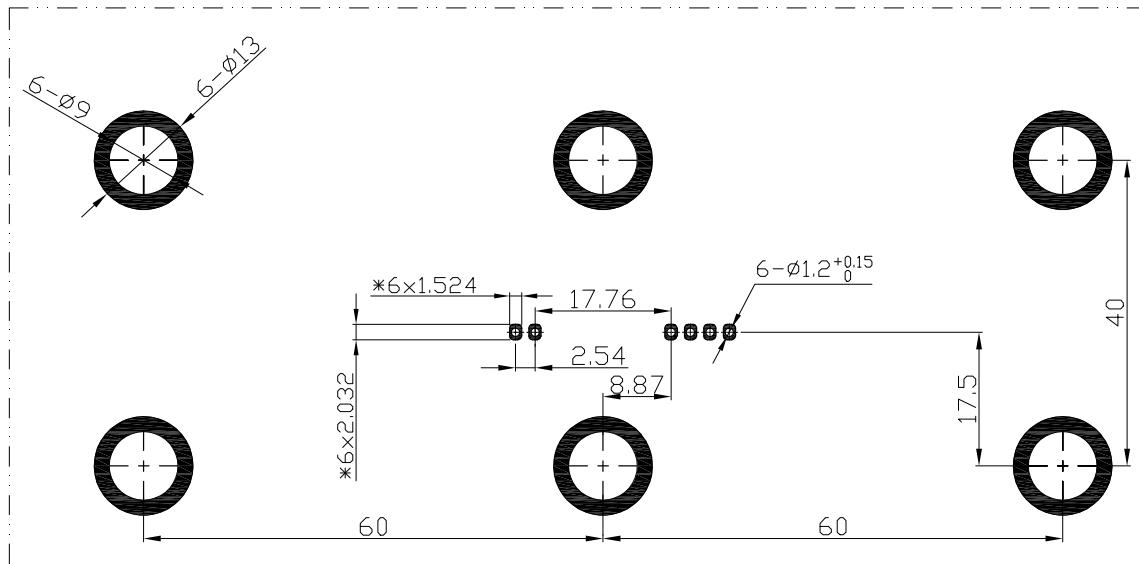


Test winding

A test winding is wound around the compensation winding. It allows simulating a primary residual current to test the function of the transducer. The output voltage V_{out} referred to V_{ref} for a test current I_T is below.

$$V_{out} - V_{ref} = G_{th} * I_T \text{ (test current)} * 20$$

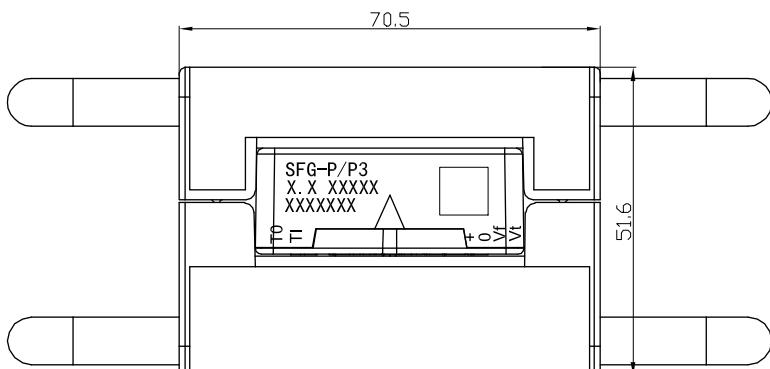
12. SFG- P/P3 PCB footprint



Assembly on PCB

- No Primary in shadow area
- Maximum PCB thickness 2.4 mm
- Wave-soldering: 260°C @ 10 s
- Recommended PCB hole diameter 1.2 mm for secondary pin.

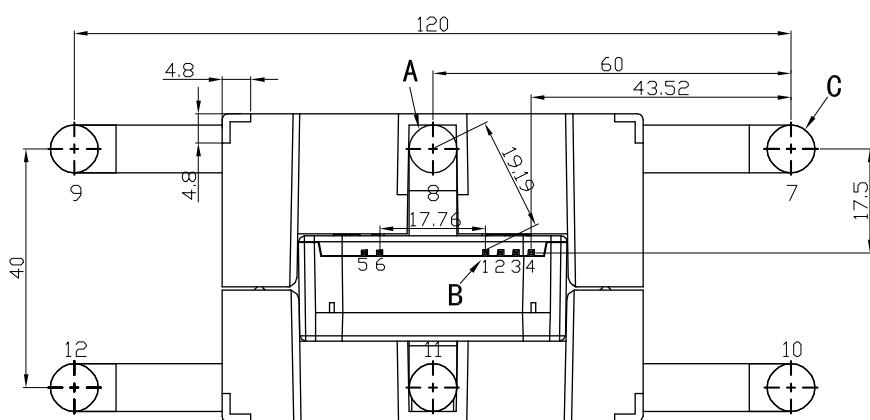
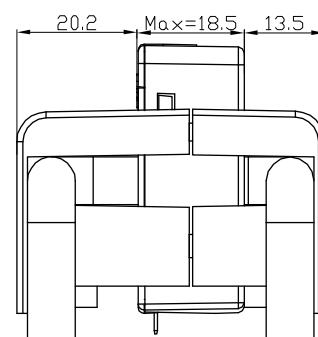
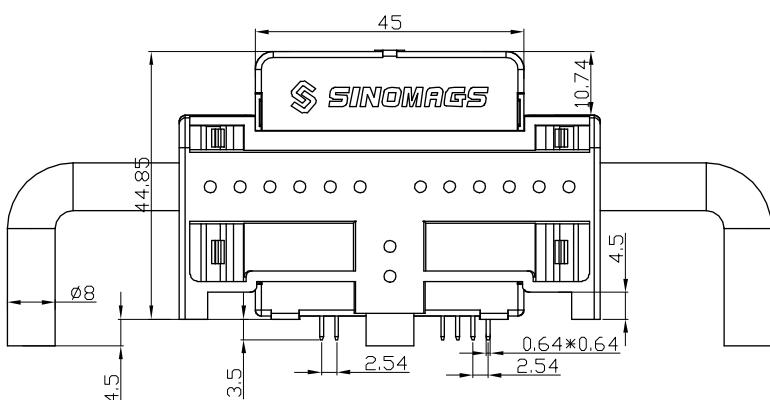
13. SFG- P/P3 Dimensions



	D _{Cl}	D _{Cp}
A-B	15.1	--
A-C	11	12
A-D	15	15

D is secondary inside the transducer

	D _{Cl}	D _{Cp}
A-B	12.1	12.1
A-C	11	47



Terminals:

1	V _{cc}	7	I _{p+}
2	GND	8	I _{p+}
3	V _{ref}	9	I _{p+}
4	V _{out}	10	I _{p-}
5	Test Out	11	I _{p-}
6	Test In	12	I _{p-}

Material : Fit UL94V-0 & RoHS
requirements ;
General tolerance : ± 0.5
Unit :mm

